

Electronic and structural characterisation of Cu₃BiS₃ thin films for the absorber layer of sustainable photovoltaics

Yakushev, M.V.; Maiello, P.; **Raadik, Taavi**; **Krustok, Jüri** Thin solid films 2014 / p. 195-199 : ill <https://doi.org/10.1016/j.tsf.2014.04.057>
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